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Multi-Measurement Prober Cable Kit

Overview

The Keithley Model 4210-MMPC-S multi-measurement prober cable kit is a collection of standard and custom connectors and accessories used to make I-V and C-V measurements using a single prober cable setup. It is also used with the Keithley Model 4225-PMU or Model 4200-PIV-A package to perform pulsed I-V measurements. This kit has been assembled for use with the Suss MicroTec PA200/300 prober series.

This document contains the following information about the installation and use of this cable kit:

- How to connect 4200A instrumentation to the prober bulkhead.
- How to install the prober cable kits, which explains how to make connections from the prober bulkhead to the prober pins.
- Specific prober cable setups:
 - I-V testing (2-wire and 4-wire).
 - C-V testing (2-wire and 4-wire).
 - Pulsed I-V measurements using the Keithley Model 4200-PIV-A.
- Pulsed I-V measurements using the Keithley Model 4225-PMU with the 4225-RPM.

NOTE

For C-V testing, this document applies to the 4200-CVU, 4210-CVU, and 4215-CVU cards. For pulsed I-V testing, this guide also applies to the 4200-PG2, 4205-PG2, 4220-PGU, and 4225-PMU pulse cards.



Prober cable kit contents

The following figure shows the cables, adapters, and supplies that are included in the 4210-MMPC-S kit.

Figure 1: Model 4210-MMPC-S multi-measurement prober cable kit



Item	Description	Part number	Quantity
1	24" full triaxial to full triaxial 100 Ω cable	CA-534-24	2
2	Triaxial plug to BNC jack	CS-712	3
3	Prober cable assembly	CA-532	1
4	7" prober ground jumper	CA-535-7	1
5	SMA jack to BNC plug	CS-1247	3
6	Triaxial tee (jack-plug-jack)	CS-737	1
7	Triaxial jack to triaxial jack adapter	CS-751	2
8	Triaxial shorting plug (shorts center pin to outer shield)	CS-1546	1
	Screw (not shown)	M3X12MMSSSOHCBLK	1

The items shipped may vary from the items in the picture.

Related documents

The following documents are available in the 4200A Learning Center and at tek.com/keithley:

- The *Model 4200A-SCS Prober and External Instrument Control* (document number 4200A-913-01).
- **White Paper 3023: Labs' Demands for Greater Measurement Flexibility Require Cabling Systems Capable of Accommodating Multiple Measurement Types.** This white paper explains the different cabling requirements for I-V, C-V, and pulse I-V testing. It also describes an example single multi-measurement cabling system.

Connecting 4200A-SCS instrumentation to the prober bulkhead

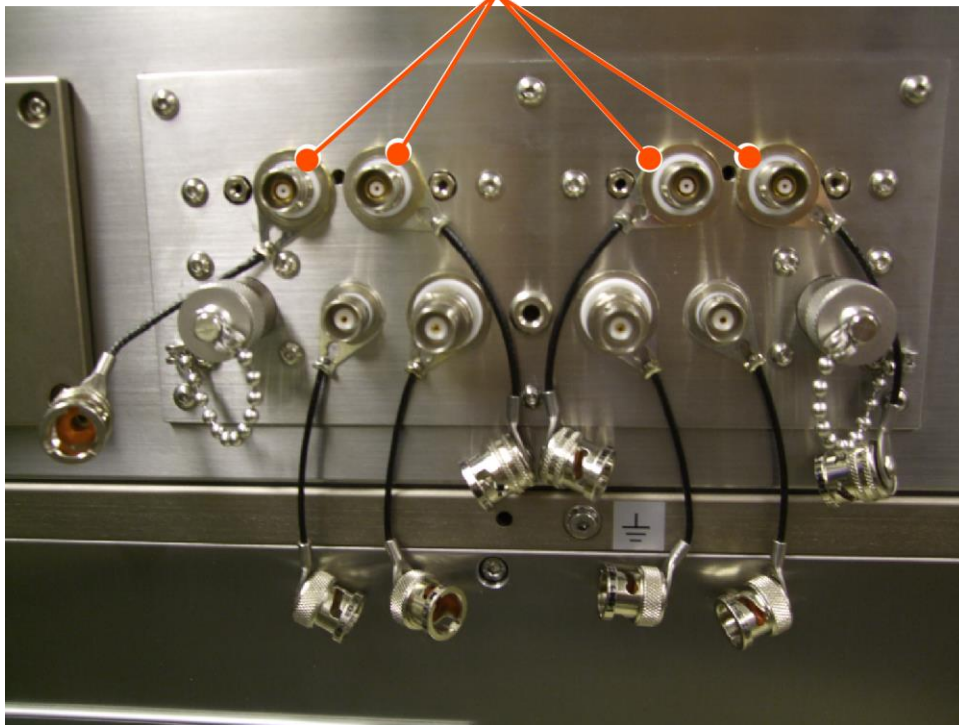
⚠ WARNING

To prevent injury or death due to electric shock, remove all power from the 4200A-SCS and shut down the Suss prober before installing the prober cable kit.

Connect the 4200A-SCS to the triaxial jacks on the prober bulkhead. The following figure shows the triaxial jacks on one of the two connection panels of the prober.

Figure 2: Prober bulkhead triaxial jacks

Standard triaxial jacks



I-V testing

For I-V testing, connect the triaxial cables of the 4200A-SCS source-measure units (SMUs) to the standard triaxial jacks on the bulkhead of the prober. The following figure shows the prober connections for two SMUs.

NOTE

The 4200A-SCS to prober portion of the following figure shows SMUs that do not use preamplifiers. These SMUs use triaxial cables that are terminated with a miniature triaxial connector on one end and a standard triaxial connector on the other end. These cables are supplied with the 4200A-SCS. If your SMUs are equipped with preamplifiers, use the supplied cables that are terminated with standard triaxial connectors on both ends. The cable diagrams after the following figure show both cables.

Figure 3: SMU connections to the prober

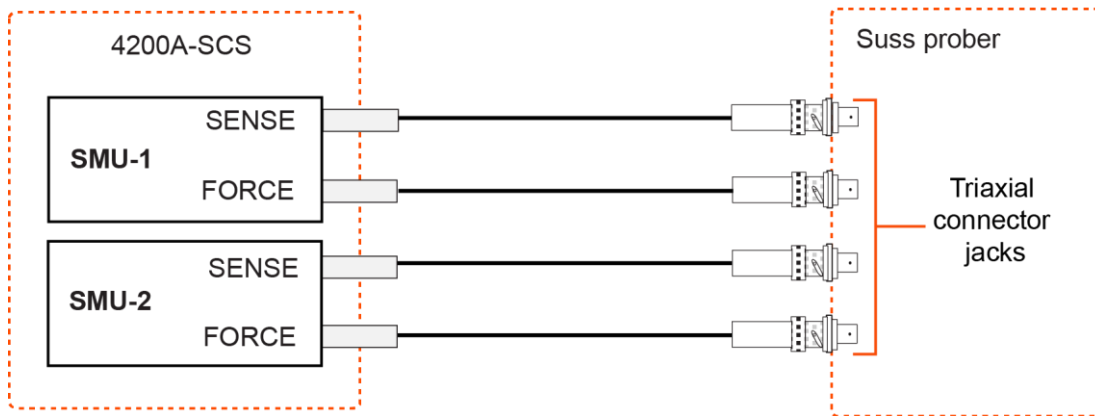
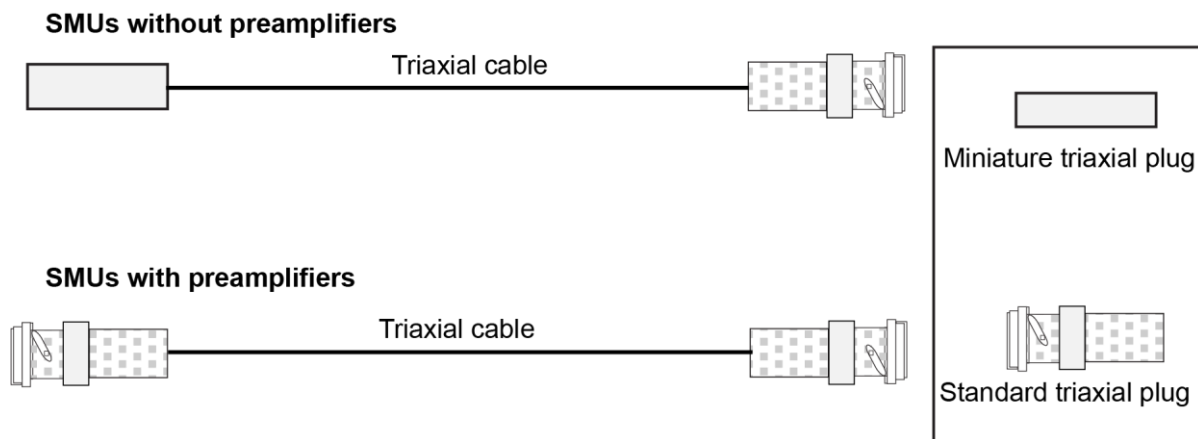


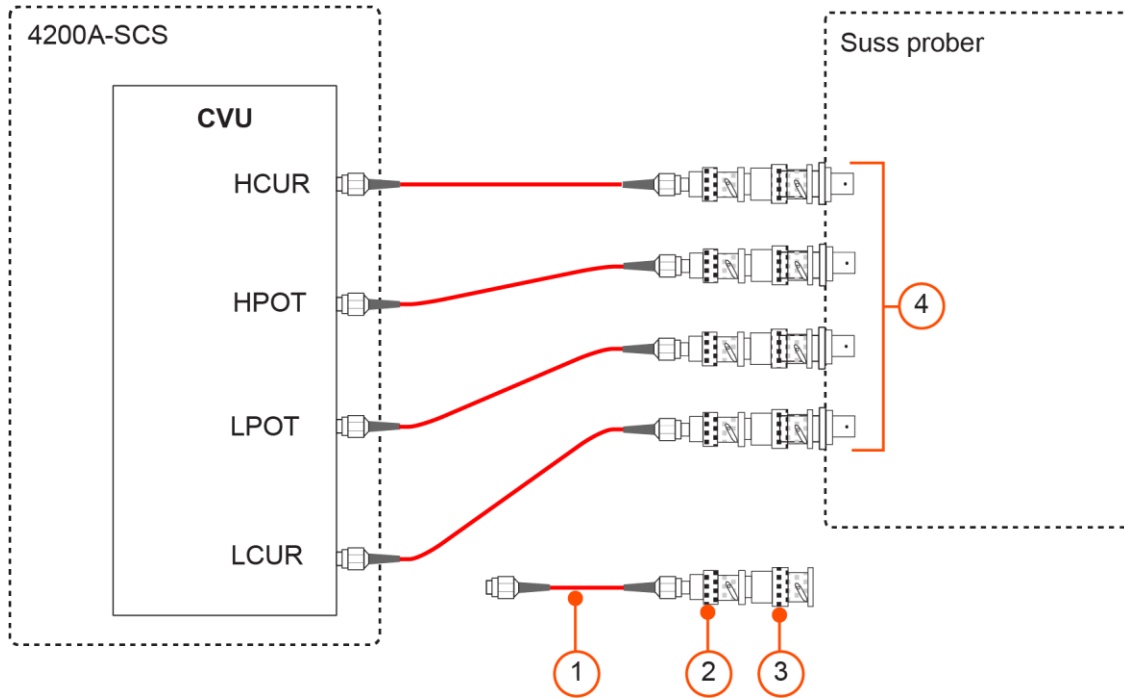
Figure 4: SMU triaxial cable diagrams



C-V testing

You need two prober cable kits to connect the subminiature version A (SMA) cables of the CVU to the triaxial jacks on the bulkhead of the prober. The following figure shows how to make the connections. Use the torque wrench supplied with the 4200A-SCS to tighten the SMA connections to 8 in. lb.

Figure 5: 4200A-SCS CVU prober connections



Item	Description	Part number
1	SMA cable (plug to plug), supplied with the CVU	Not applicable
2	SMA jack to BNC plug	CS-1247
3	BNC jack to triaxial plug	CS-712
4	Triaxial jacks	Not applicable

Pulsed I-V testing using the Keithley Model 4200-PIV-A

NOTE

The 4200-PIV-A is no longer available. These instructions are provided for customers who have previously purchased the 4200-PIV-A accessory.

NOTE

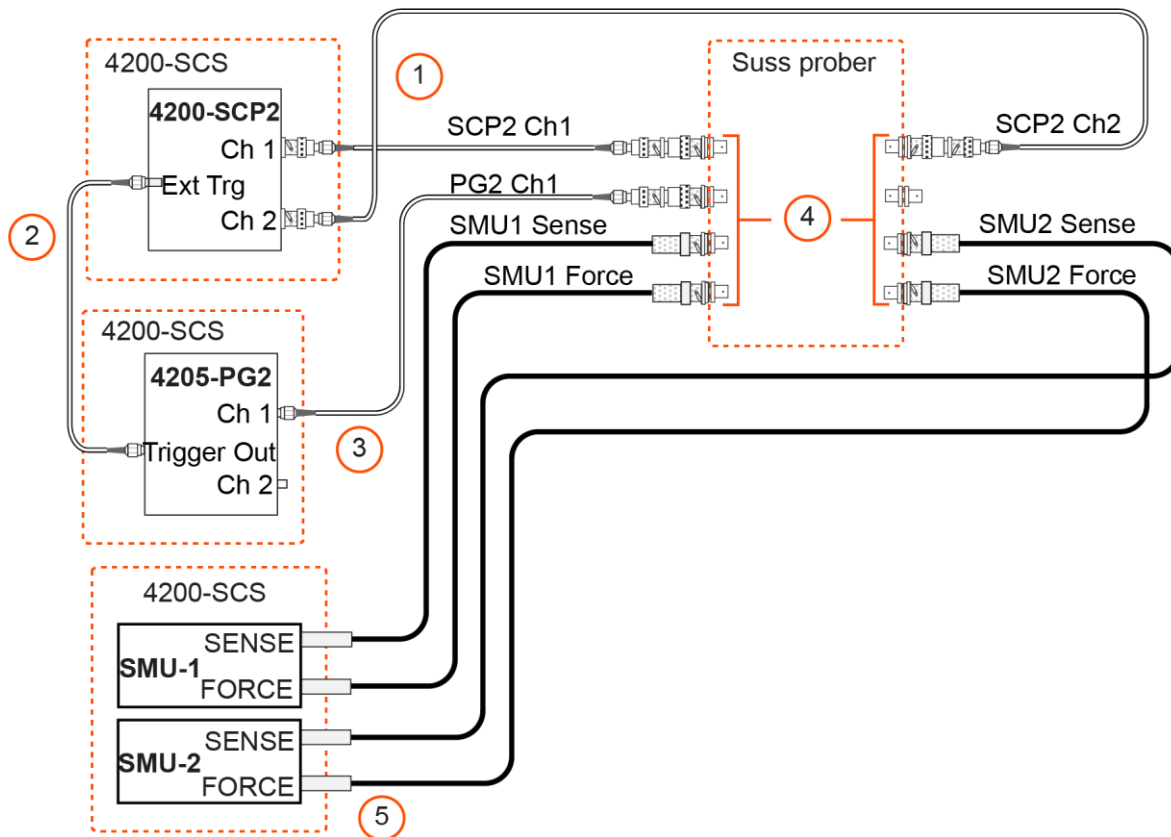
Four 4210-MMPC-S prober cable kits are required for 4-pin, PIV-A pulsed I-V testing.

You can perform 4-pin pulsed I-V measurements using four 4210-MMPC-S prober cable kits with the Keithley 4200-PIV-A package, which includes a scope card, pulse generator card, software, and other components.

Use the supplied cables and connectors to connect the Model 4200 to the bulkhead of the prober. Use the torque wrench supplied with the 4200A-SCS to tighten the SMA connections to 8 in. lb.

See the following figures for details of the connections, cables, and adapters.

Figure 6: Model 4200-PIV-A instrumentation connections

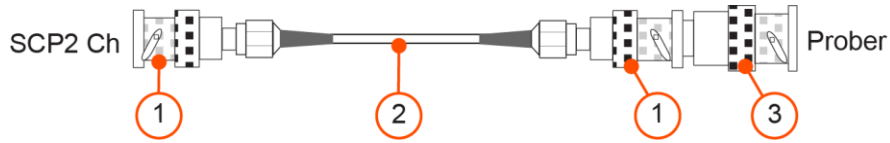


Item	Description
1	See figure "SCP2 connection to Suss prober."
2	Trigger. See figure "Trigger connection between SCP2 and PG2."
3	See figure "PG2 connection to prober."
4	Triaxial jacks.
5	See figure "SMU connection to prober."

NOTE

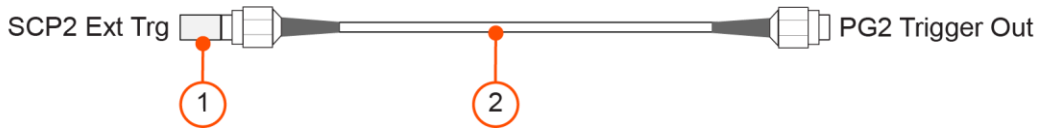
The previous figure shows source-measure units (SMUs) that are not equipped with preamplifiers. These SMUs use the supplied triaxial cables that are terminated with a miniature triaxial connector on one end and a standard triaxial connector on the other end. If your SMUs are equipped with preamplifiers, use the supplied cables that are terminated with standard triaxial connectors on both ends. The following figures shows both cables.

Figure 7: SCP2 connection to Suss prober



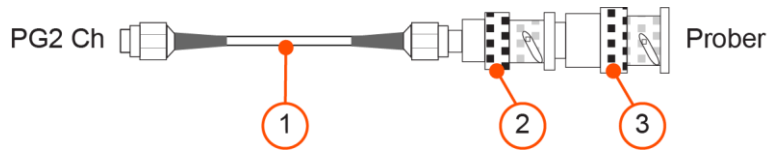
Item	Description	Part number	Notes
1	SMA jack to BNC plug	CS-1247	Triaxial connectors.
2	2 m SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.
3	BNC jack to triaxial plug	CS-712	

Figure 8: Trigger connection between SCP2 and PG2



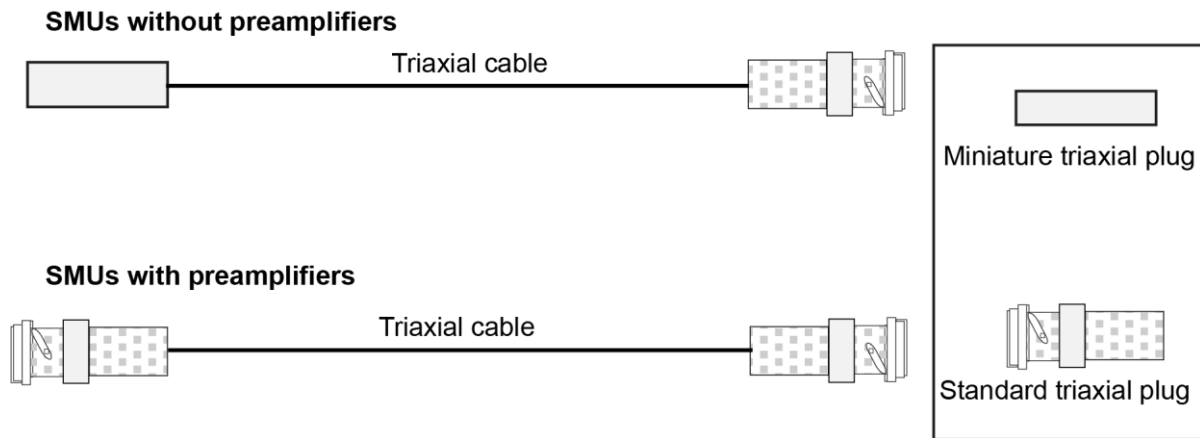
Item	Description	Part number	Notes
1	SMA jack to SMA plug	Not applicable	Supplied with the 4200-PIV-A.
2	4.25" SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.

Figure 9: PG2 connection to prober



Item	Description	Part number	Notes
1	2 m SMA cable (plug to plug)	Not applicable	Triaxial connectors.
2	SMA jack to BNC plug	CS-1247	
3	BNC jack to triaxial plug	CS-712	

Figure 10: SMU triaxial cable diagrams



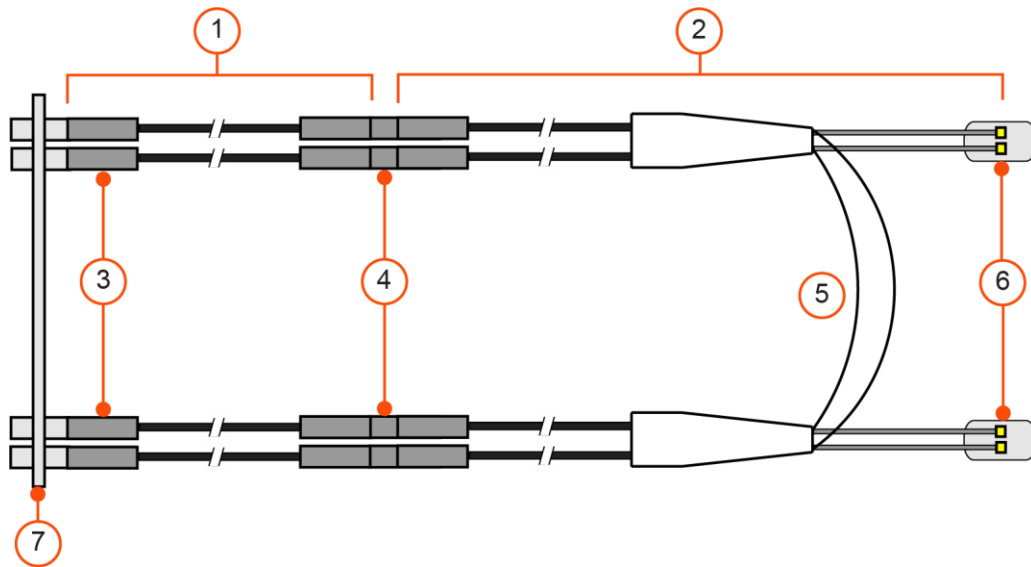
Basic cable kit setup

The following figure shows the basic cable setup for the 2-pin I-V and 2-pin C-V testing scenarios described in this document. The 4-pin I-V and 4-pin C-V testing scenarios require minor setup changes. Pulsed I-V setup, which is more complex, is described in [Usage scenarios](#) (on page 10).

NOTE

This setup requires two 4210-MMPC-S kits.

Figure 11: Basic 2-pin prober cable setup



Item	Description	Part number	Quantity	Notes
1	Triaxial to triaxial cables	CA-534-24	2	
2	Prober cable assembly	CA-532	2	
3	Connect to prober bulkhead triaxial connectors	Not applicable		
4	Triaxial jack to triaxial jack adapters	CS-751	4	
5	Jumpers	CA-535-7	2	The jumpers connect the commons of the two cable assemblies.
6	Connect to prober pin	Not applicable		
7	Prober bulkhead	Not applicable		Triaxial connectors.

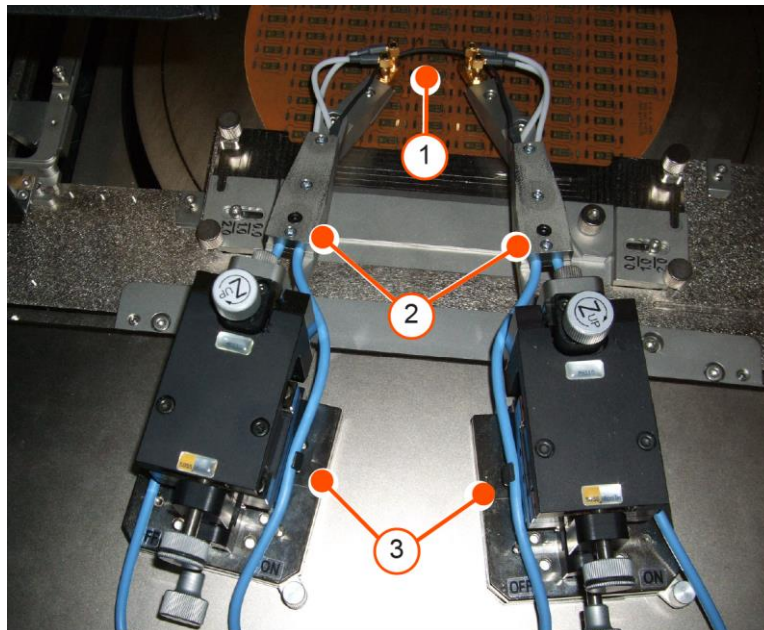
Installation guidelines

The following figure shows the prober cable assemblies of two 4210-MMPC-S kits installed in a Suss MicroTec PA300 prober.

To install the Suss prober kit:

1. Secure each prober cable assembly to the manipulator using a single mounting screw (2), as shown in the following figure.

Figure 12: Two prober cable assemblies installed in Suss prober



Item	Description
1	Jumper to connect the commons of the two cable assemblies
2	Mounting screws
3	Cable clamps (2 of 4)

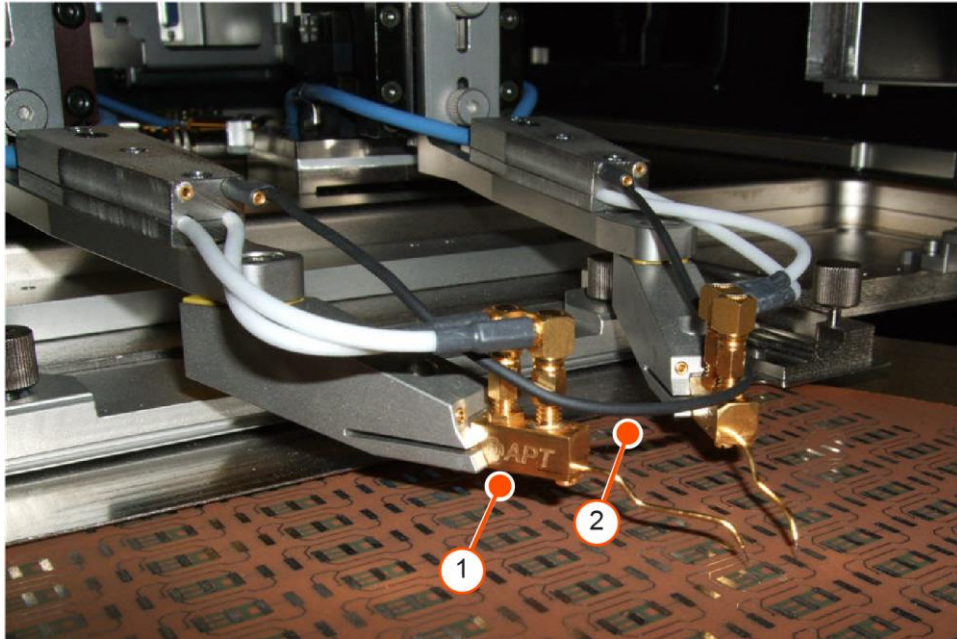
2. Route the blue cables along the sides of the manipulators.
3. Use the cable clamps (3) to firmly secure the cables to the manipulators. Make sure the clamps are tight enough to keep the cables from moving.
4. Connect a black jumper from one cable assembly to the other (1). The jumper plugs into the ends of the assembly blocks.

NOTE

It is good practice to install the second jumper. This improves the connection and provides secure extra jumper storage. The following figure shows another view of the jumper (2).

5. Connect the cable wires of the cable assemblies to the APT probe tips, as shown in the following figure.

Figure 13: Front view of the installed prober cable assemblies



Item	Description
1	APT probe tip
2	Jumper

NOTE

When routing the wires, consider the possible movements of the manipulators. The previous figure demonstrates proper routing of the jumper and cable wires.

6. Connect the triaxial-to-triaxial cables to the triaxial connectors on the prober bulkhead. Refer to [Basic cable kit setup](#) (on page 8).
7. Connect the other ends of the triaxial cables to the prober cable assemblies using the supplied triaxial jack to triaxial jack adapters.

Usage scenarios

The following usage scenarios provide information on how to set up 2-pin and 4-pin I-V tests, 2-pin and 4-pin C-V tests, and pulsed I-V tests.

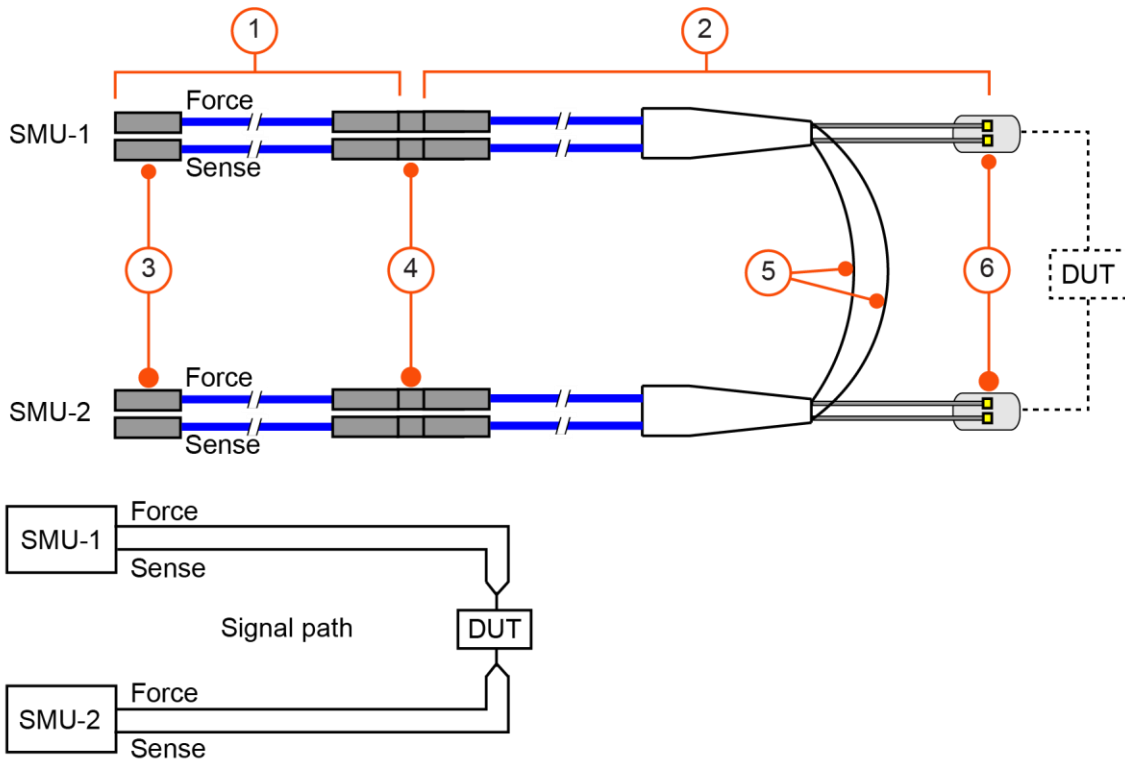
I-V testing: 2-pin I-V setup

NOTE

The setup for 2-pin I-V testing requires two 4210-MMPC-S prober cable kits.

This setup assumes that two 4200A-SCS SMUs are connected to the prober bulkhead. Use the setup shown in the following figure to perform 2-pin I-V testing. For SMU connections that are connected to the outside of the bulkhead, see [I-V testing](#) (on page 4).

Figure 14: Test setup for 2-pin I-V testing



Item	Description	Part number	Notes
1	Triaxial to triaxial cables	CA-534-24	
2	Prober cable assembly	CA-532	
3	Connect to prober bulkhead triaxial connectors	Not applicable	
4	Triaxial jack to triaxial jack adapters	CS-751	
5	Jumpers	CA-535-7	The jumpers connect the commons of the two cable assemblies.
6	Connect to prober pin	Not applicable	

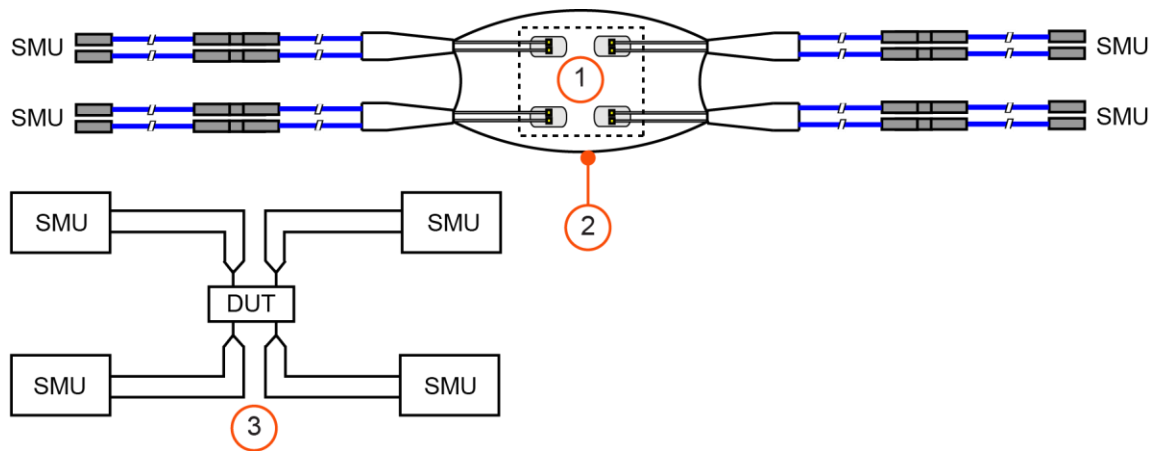
I-V testing: 4-pin I-V setup

NOTE

The setup for 4-pin I-V testing requires four 4210-MMPC-S prober cable kits.

With four SMUs connected to the prober bulkhead, use the setup shown in the following figure to perform 4-pin I-V testing. The figure in [I-V testing](#) (on page 4) shows two SMUs connected to one of the bulkhead connection panels. Connect two additional SMUs to the other bulkhead connection panel.

Figure 15: Test setup for 4-pin I-V testing



Item	Description	Notes
1	4-terminal DUT	
2	Jumpers (1 of 4)	The four jumpers connect the commons of the four cable assemblies.
3	Signal path	

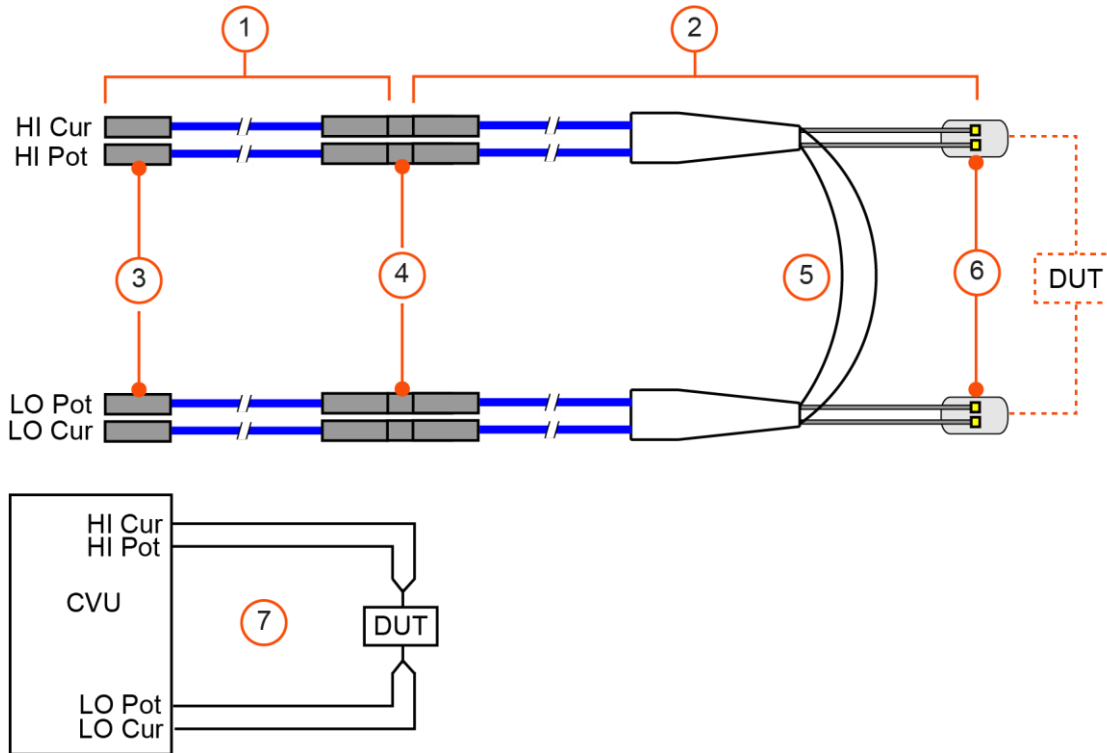
C-V testing: 2-pin C-V setup

With a CVU connected to the prober bulkhead, use the fundamental setup shown in [C-V testing](#) (on page 5) to perform 2-pin C-V testing. The following figure shows the CVU connections to the outside of the bulkhead.

NOTE

The set up for 2-pin C-V testing requires two 4210-MMPC-S prober cable kits.

Figure 16: Test setup for 2-pin C-V testing



Item	Description	Part number	Notes
1	Triaxial to triaxial cables	CA-534-24	
2	Prober cable assembly	CA-532	
3	Connect to prober bulkhead triaxial connectors	Not applicable	
4	Triaxial jack to triaxial jack adapters	CS-751	
5	Jumpers	CA-535-7	The jumpers connect the commons of the two cable assemblies.
6	Connect to prober pin	Not applicable	
7	Signal path	Not applicable	

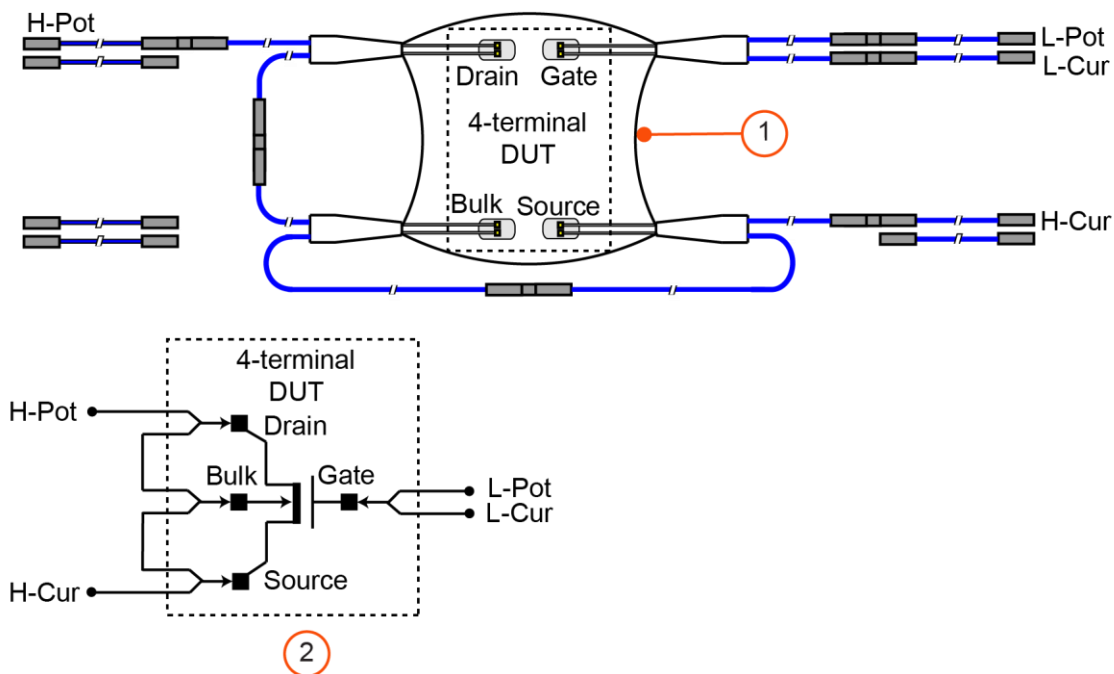
C-V testing: 4-pin C-V setup

NOTE

The setup for 4-pin C-V testing requires four 4210-MMPC-S prober cable kits.

A typical test for a field effect transistor (FET) is to connect the drain, bulk, and source together and make the measurement across the gate. With a CVU connected to the prober bulkhead, use the setup shown in the following figure to perform 4-pin C-V testing.

Figure 17: Test setup for 4-pin C-V testing



Item	Description	Notes
1	Jumpers (1 of 4)	The four jumpers connect the commons of the four cable assemblies.
2	Signal path	

Four-pin pulsed I-V test setup using the Keithley Model 4200-PIV-A

NOTE

The 4200-PIV-A is no longer available. These instructions are provided for customers who have previously purchased the 4200-PIV-A accessory.

NOTE

The setup for 4-pin pulsed I-V testing requires four prober cable kits.

The Model 4200-PIV-A is a factory-installed package that includes a scope card, pulse generator card, software, and other components to perform 4-pin pulsed I-V measurements.

The test setup for using the Model 4200-PIV-A is shown in the following figures.

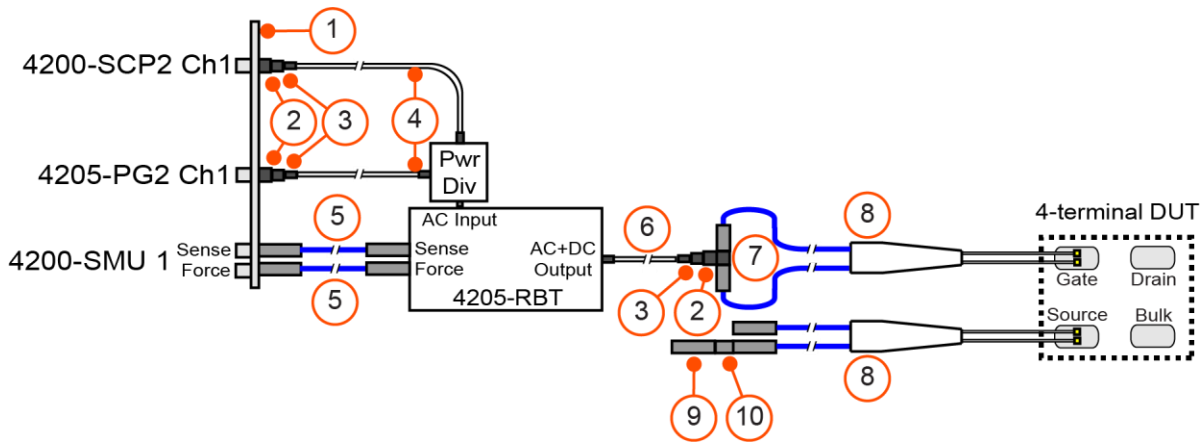
NOTE

Details on using the Model 4200-PIV-A package are provided in the *Model 4200-SCS User's Manual*. See the topic "How to use the Model 4200-SCS to perform a pulsed I-V test on my device."

See [Pulsed I-V testing using the Keithley Model 4200-PIV-A](#) (on page 5) to see how the Model 4200 connects to the outside of the bulkhead.

The following figure shows the connections from the prober bulkhead to the gate and source of the 4-terminal device.

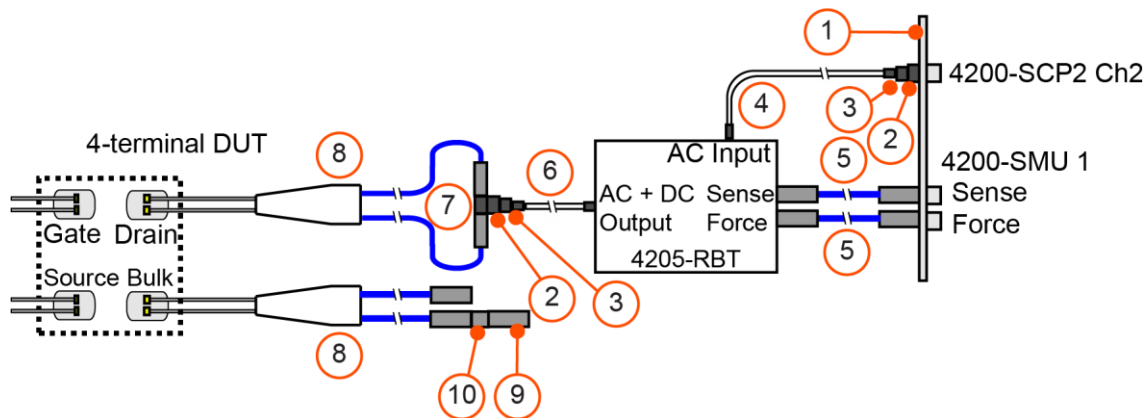
Figure 18: Connections to the gate and source of the DUT



Item	Description	Part number	Notes
1	Prober bulkhead		Triaxial connectors.
2	BNC jack to triaxial plug	CS-712	
3	SMA jack to BNC plug	CS-1247	
4	2 m SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.
5	24" triaxial to triaxial 100 Ω cable	CA-534-24	
6	6" SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.
7	Triaxial tee	CS-737	
8	MMPC prober cable assembly	CA-532	
9	Mini-triaxial shorting plug	CS-1546	The mini-triaxial shorting plug connects the center conductor of the triaxial cable to the outer shield. This connects DUT LO to pulse generator low.
10	Triaxial jack to triaxial jack adapter	CS-751	

The following figure shows the connections from the bulkhead to the drain and bulk.

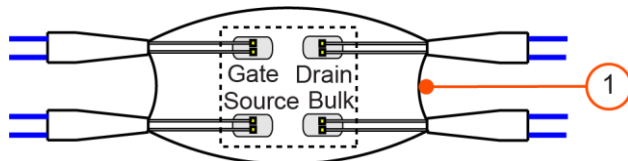
Figure 19: Connections to the drain and bulk



Item	Description	Part number	Notes
1	Prober bulkhead		Triaxial connectors.
2	BNC jack to triaxial plug	CS-712	
3	SMA jack to BNC plug	CS-1247	
4	2 m SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.
5	24" triaxial to triaxial 100 Ω cable	CA-534-24	
6	6" SMA cable (plug to plug)	Not applicable	Supplied with the 4200-PIV-A.
7	Triaxial tee	CS-737	
8	MMPC prober cable assembly	CA-532	
9	Mini-triaxial shorting plug	CS-1546	The mini-triaxial shorting plug connects the center conductor of the triaxial cable to the outer shield. This connects DUT LO to pulse generator low.
10	Triaxial jack to triaxial jack adapter	CS-751	

The following figure shows the jumper connections.

Figure 20: Jumper connections for 4-terminal DUTs



Item	Description	Part number	Notes
1	Jumper (1 to 4)	CA-535-7	The four jumpers connect the commons of the four cable assemblies.

Set up the Keithley Model 4225-PMU for pulsed I-V measurements

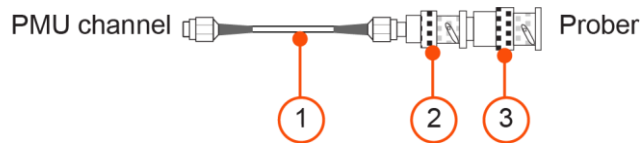
NOTE

The setup for four-pin pulsed I-V testing requires four 4210-MMPC-S prober cable kits.

The Model 4225-PMU has two channels of voltage pulse source with integrated simultaneous voltage and current measurement.

The following figure shows the cable and adapters needed to connect a PMU channel to the prober bulkhead. Use the torque wrench supplied with the 4200A-SCS to tighten the SMA connections to 8 in. lb.

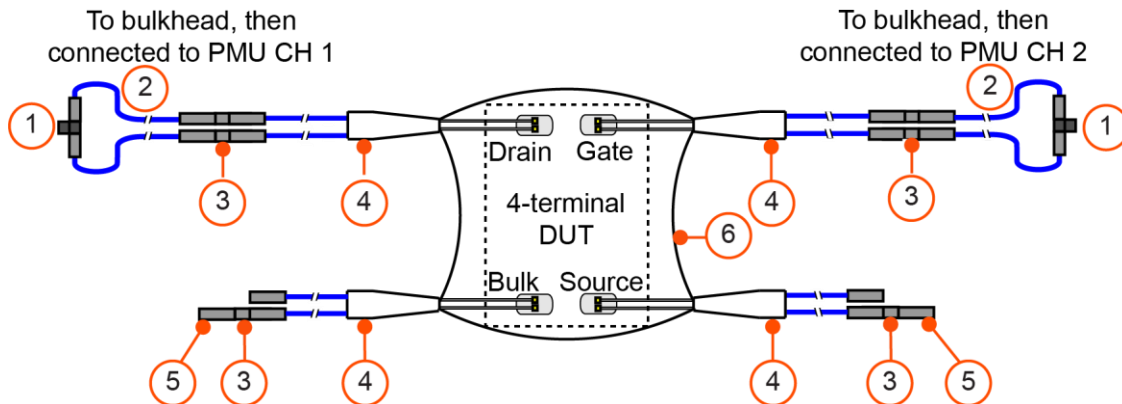
Figure 21: Cable and adapters used to connect PMU channel to prober bulkhead



Item	Description	Part number	Notes
1	SMA cable (plug to plug), 2 m	Not applicable	Supplied with the PMU.
2	SMA jack to BNC plug	CS-1247	
3	BNC jack to triaxial plug	CS-712	

The following figure shows a typical prober connection setup for testing a four-pin device.

Figure 22: Basic 4-pin prober setup for PMU



Item	Description	Part number	Notes
1	Triaxial tee	CS-737	
2	Triaxial to triaxial 100 Ω cable	CA-534-24	
3	Triaxial jack to triaxial jack adapter	CS-751	
4	MMPC prober cable assembly	CA-532	
5	Triaxial shorting plug	CS-1546	The triaxial shorting plug connects the center conductor of the triaxial cable to the outer shield. This connects DUT LO to pulse generator low.
6	Jumper (1 of 4)	CA-535-7	The four jumpers connect the commons of the four cable assemblies.

Setup using the Keithley Model 4225-RPM for I-V, C-V, or pulsed I-V measurements

NOTE

The setup for three-pin pulsed I-V testing requires three prober cable kits. The setups for four-pin testing require four prober cable kits.

The Model 4225-RPM Remote Amplifier/Switch is an optional accessory for the Model 4225-PMU. The PMU has two channels and each channel can support an RPM. The MMPC cables simplify the connection and re-connection between the instruments and the device-under-test. The combination of the MMPC cables with the RPM permits testing I-V, C-V, or pulsed I-V automatically, without any manual cable reconnections. When using only two RPMs on a four-terminal device, some re-cabling is required for certain C-V test configurations.

The 4225-RPM has the appropriate connector types at the input and output of the RPM enclosure to eliminate any adapters when connecting cables to the RPM. On the input side, there are two triaxial connectors for SMU Force and SMU Sense. There are two SMA connectors for CVU POT and CVU CUR. There is also an RPM control connector for the control and power of the RPM from the 4225-PMU. The output of the RPM is a pair of triaxial cables (Force and Sense), which connect directly to the MMPC cables as shown in the following figure.

See the *Model 4200A-SCS Pulse Card (PGU and PMU) User's Manual* for Model 4225-PMU and Model 4225-RPM information and how to configure an ITM for a pulsed I-V test.

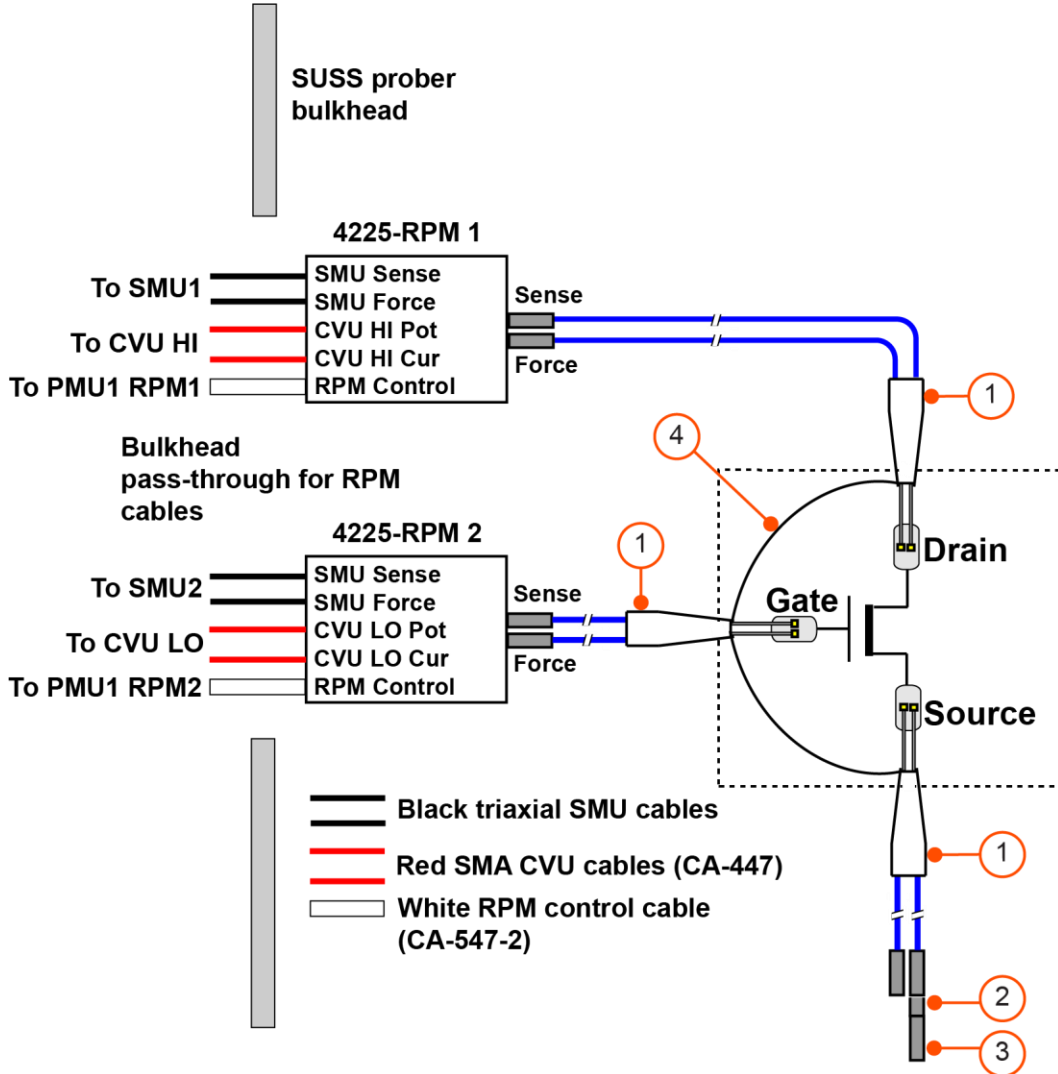
2 channel I-V or pulsed I-V setup

For most I-V and pulsed I-V testing, only two source/measure channels are typically used. The two active signals are connected to the gate and drain, and the source (and bulk, if present) is connected to ground. See the following two figures.

NOTE

The three-pin setup requires three 4210-MMPC-S kits.

Figure 23: Test setup for a 3-pin device using 2-channel I-V and pulsed I-V

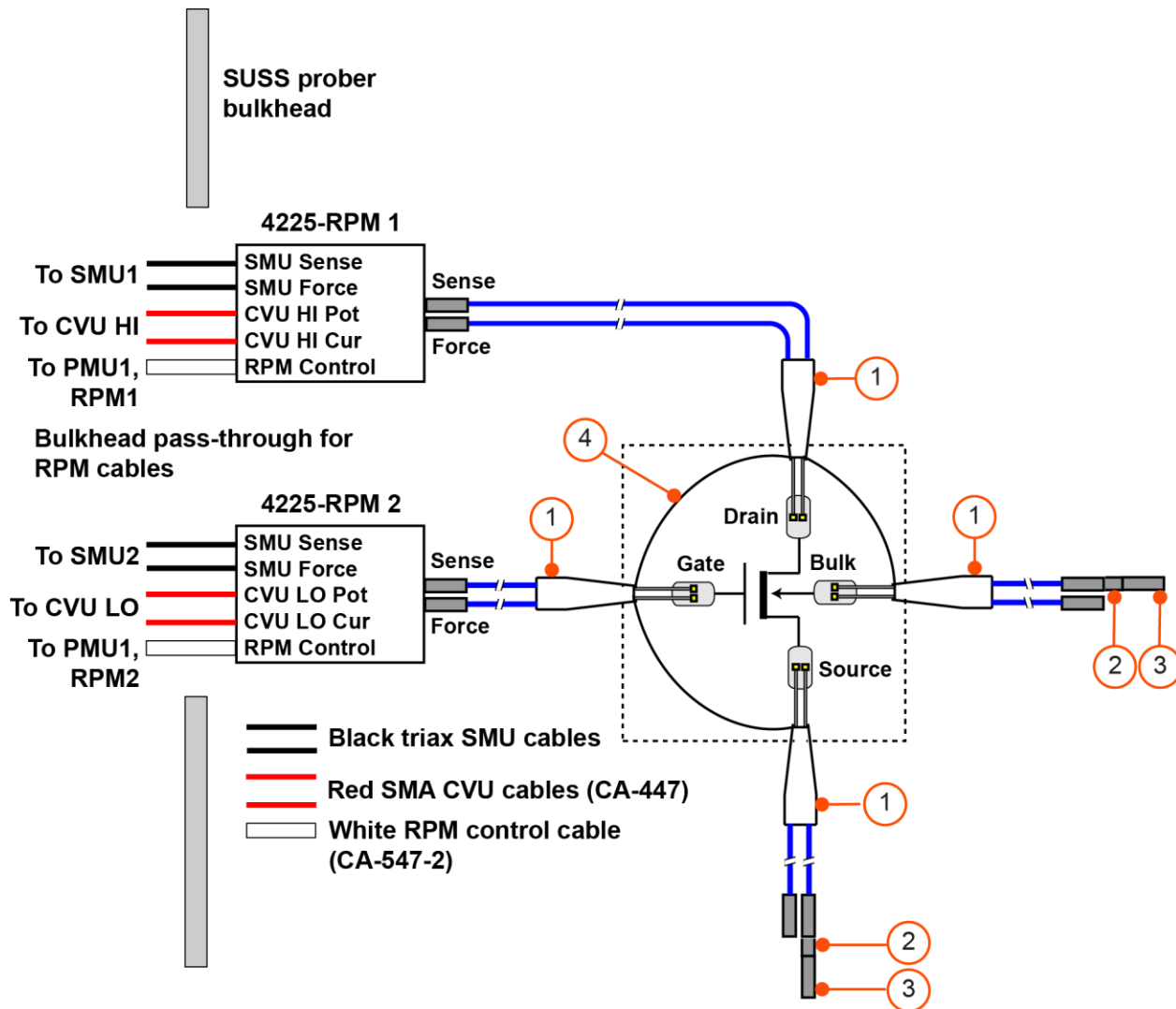


Item	Description	Part number	Notes
1	Prober cable assembly	CA-532	
2	Triaxial jack to triaxial jack adapter	CS-751	
3	Triaxial shorting plug	CS-1546	The shorting plug connects the center conductor of the triaxial cable to the outer shield. This connects DUT LO to pulse generator low.
4	Ground jumper (1 of 2)	CA-535-7	The two jumpers connect the commons of the three cable assemblies.

NOTE

The four-pin setup requires four 4210-MMPC-S kits.

Figure 24: Test setup for 4-pin device using 2-channel I-V and pulsed I-V



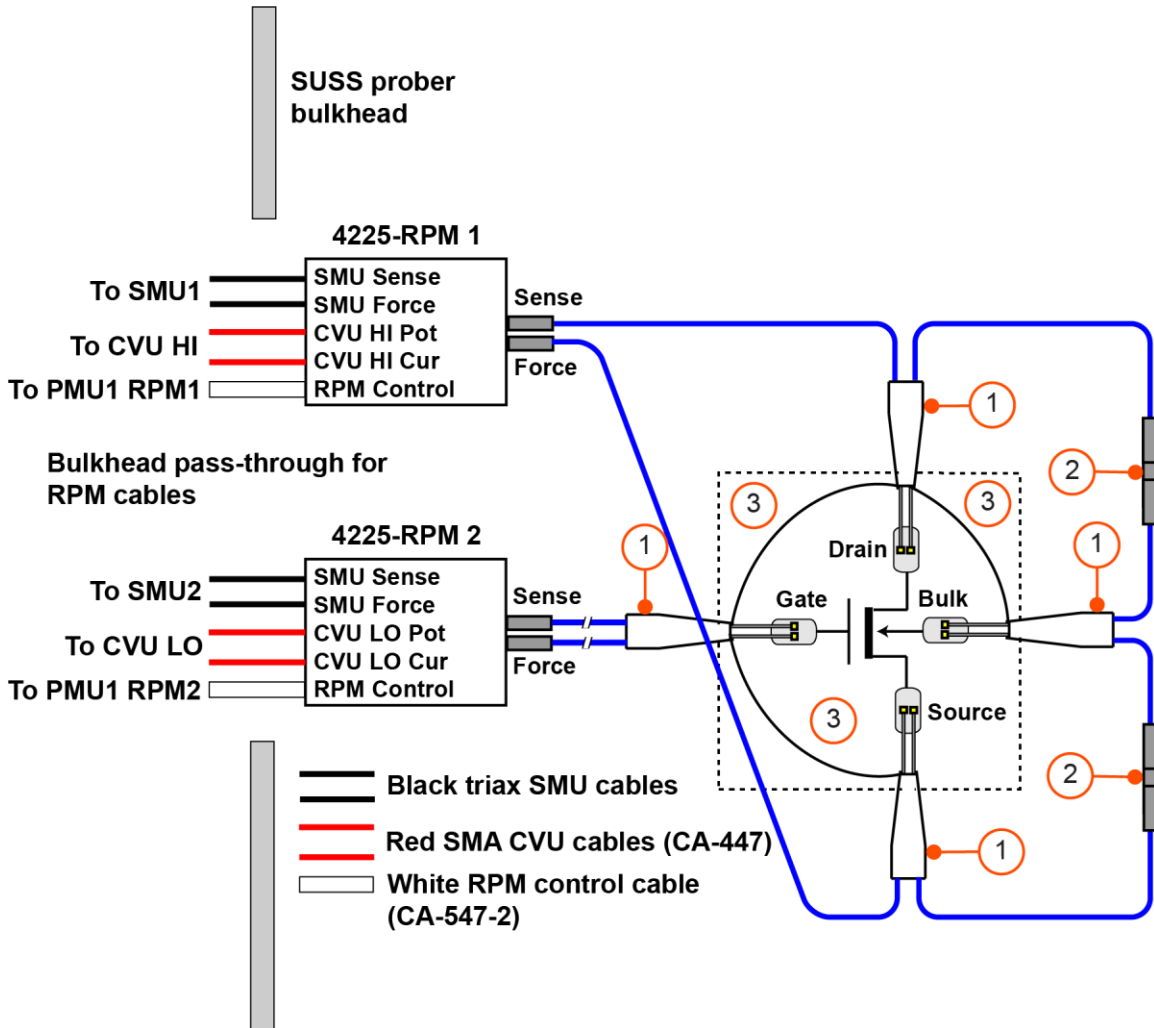
Item	Description	Part number	Notes
1	Prober cable assembly	CA-532	
2	Triaxial jack to triaxial jack adapter	CS-751	
3	Triaxial shorting plug	CS-1546	The shorting plug connects the center conductor of the triaxial cable to the outer shield. This connects DUT LO to pulse generator low.
4	Ground jumper (1 of 2)	CA-535-7	The three jumpers connect the commons of the four cable assemblies.

For the C-V test setup shown in the following figure, all four source/measure channels are used.

NOTE

The four-pin setup requires four 4210-MMPC-S kits.

Figure 25: Test setup for 4-terminal C-V testing



Item	Description	Part number	Notes
1	Prober cable assembly	CA-532	
2	Triaxial jack to triaxial jack adapter	CS-751	
3	Ground jumper (1 of 2)	CA-535-7	The three jumpers connect the commons of the four cable assemblies.

The following safety precautions should be observed before using this product and any associated instrumentation. Although some instruments and accessories would normally be used with nonhazardous voltages, there are situations where hazardous conditions may be present.

This product is intended for use by personnel who recognize shock hazards and are familiar with the safety precautions required to avoid possible injury. Read and follow all installation, operation, and maintenance information carefully before using the product. Refer to the user documentation for complete product specifications.

If the product is used in a manner not specified, the protection provided by the product warranty may be impaired.

The types of product users are:

Responsible body is the individual or group responsible for the use and maintenance of equipment, for ensuring that the equipment is operated within its specifications and operating limits, and for ensuring that operators are adequately trained.

Operators use the product for its intended function. They must be trained in electrical safety procedures and proper use of the instrument. They must be protected from electric shock and contact with hazardous live circuits.

Maintenance personnel perform routine procedures on the product to keep it operating properly, for example, setting the line voltage or replacing consumable materials. Maintenance procedures are described in the user documentation. The procedures explicitly state if the operator may perform them. Otherwise, they should be performed only by service personnel.

Service personnel are trained to work on live circuits, perform safe installations, and repair products. Only properly trained service personnel may perform installation and service procedures.

Keithley products are designed for use with electrical signals that are measurement, control, and data I/O connections, with low transient overvoltages, and must not be directly connected to mains voltage or to voltage sources with high transient overvoltages. Measurement Category II (as referenced in IEC 60664) connections require protection for high transient overvoltages often associated with local AC mains connections. Certain Keithley measuring instruments may be connected to mains. These instruments will be marked as category II or higher.

Unless explicitly allowed in the specifications, operating manual, and instrument labels, do not connect any instrument to mains.

Exercise extreme caution when a shock hazard is present. Lethal voltage may be present on cable connector jacks or test fixtures. The American National Standards Institute (ANSI) states that a shock hazard exists when voltage levels greater than 30 V RMS, 42.4 V peak, or 60 VDC are present. A good safety practice is to expect that hazardous voltage is present in any unknown circuit before measuring.

Operators of this product must be protected from electric shock at all times. The responsible body must ensure that operators are prevented access and/or insulated from every connection point. In some cases, connections must be exposed to potential human contact. Product operators in these circumstances must be trained to protect themselves from the risk of electric shock. If the circuit is capable of operating at or above 1000 V, no conductive part of the circuit may be exposed.

Do not connect switching cards directly to unlimited power circuits. They are intended to be used with impedance-limited sources. NEVER connect switching cards directly to AC mains. When connecting sources to switching cards, install protective devices to limit fault current and voltage to the card.

Before operating an instrument, ensure that the line cord is connected to a properly-grounded power receptacle. Inspect the connecting cables, test leads, and jumpers for possible wear, cracks, or breaks before each use.

When installing equipment where access to the main power cord is restricted, such as rack mounting, a separate main input power disconnect device must be provided in close proximity to the equipment and within easy reach of the operator.

For maximum safety, do not touch the product, test cables, or any other instruments while power is applied to the circuit under test. ALWAYS remove power from the entire test system and discharge any capacitors before connecting or disconnecting cables or jumpers, installing or removing switching cards, or making internal changes, such as installing or removing jumpers.

Do not touch any object that could provide a current path to the common side of the circuit under test or power line (earth) ground. Always make measurements with dry hands while standing on a dry, insulated surface capable of withstanding the voltage being measured.


For safety, instruments and accessories must be used in accordance with the operating instructions. If the instruments or accessories are used in a manner not specified in the operating instructions, the protection provided by the equipment may be impaired.


Do not exceed the maximum signal levels of the instruments and accessories. Maximum signal levels are defined in the specifications and operating information and shown on the instrument panels, test fixture panels, and switching cards.


When fuses are used in a product, replace with the same type and rating for continued protection against fire hazard.

Chassis connections must only be used as shield connections for measuring circuits, NOT as protective earth (safety ground) connections.

If you are using a test fixture, keep the lid closed while power is applied to the device under test. Safe operation requires the use of a lid interlock.


If a  screw is present, connect it to protective earth (safety ground) using the wire recommended in the user documentation.

The  symbol on an instrument means caution, risk of hazard. The user must refer to the operating instructions located in the user documentation in all cases where the symbol is marked on the instrument.

The  symbol on an instrument means warning, risk of electric shock. Use standard safety precautions to avoid personal contact with these voltages.


The  symbol on an instrument shows that the surface may be hot. Avoid personal contact to prevent burns.

The  symbol indicates a connection terminal to the equipment frame.

If this  symbol is on a product, it indicates that mercury is present in the display lamp. Please note that the lamp must be properly disposed of according to federal, state, and local laws.

The **WARNING** heading in the user documentation explains hazards that might result in personal injury or death. Always read the associated information very carefully before performing the indicated procedure.

The **CAUTION** heading in the user documentation explains hazards that could damage the instrument. Such damage may invalidate the warranty.

The **CAUTION** heading with the  symbol in the user documentation explains hazards that could result in moderate or minor injury or damage the instrument. Always read the associated information very carefully before performing the indicated procedure. Damage to the instrument may invalidate the warranty.

Instrumentation and accessories shall not be connected to humans.

Before performing any maintenance, disconnect the line cord and all test cables.

To maintain protection from electric shock and fire, replacement components in mains circuits — including the power transformer, test leads, and input jacks — must be purchased from Keithley. Standard fuses with applicable national safety approvals may be used if the rating and type are the same. The detachable mains power cord provided with the instrument may only be replaced with a similarly rated power cord. Other components that are not safety-related may be purchased from other suppliers as long as they are equivalent to the original component (note that selected parts should be purchased only through Keithley to maintain accuracy and functionality of the product). If you are unsure about the applicability of a replacement component, call a Keithley office for information.

Unless otherwise noted in product-specific literature, Keithley instruments are designed to operate indoors only, in the following environment: Altitude at or below 2,000 m (6,562 ft); temperature 0 °C to 50 °C (32 °F to 122 °F); and pollution degree 1 or 2.

To clean an instrument, use a cloth dampened with deionized water or mild, water-based cleaner. Clean the exterior of the instrument only. Do not apply cleaner directly to the instrument or allow liquids to enter or spill on the instrument. Products that consist of a circuit board with no case or chassis (e.g., a data acquisition board for installation into a computer) should never require cleaning if handled according to instructions. If the board becomes contaminated and operation is affected, the board should be returned to the factory for proper cleaning/servicing.

Safety precaution revision as of June 2018.